## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10596589	MARUYAMA ET AL.
Examiner	Art Unit
Elizabeth Burkhart	1715

SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES			
Search Notes	Date	Examiner	
STIC search	7/2/2009	EB	
eDAN inventor search & EAST with key terms (See history) & NPL search-Google Scholar with key terms	10/9/2009	EB	
Updated Search (see history), NPL Search-Google Scholar with key terms	4/7/2010	EB	

INTERFERENCE SEARCH				
Class		Subclass	Date	Examiner
427	255.28		4/7/2010	EB

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